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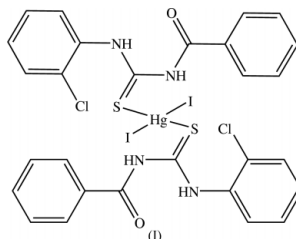
Key indicators

Single-crystal X-ray study
 $T = 293\text{ K}$
Mean $\sigma(\text{C}-\text{C}) = 0.010\text{ \AA}$
 R factor = 0.042
 wR factor = 0.098
Data-to-parameter ratio = 20.1For details of how these key indicators were automatically derived from the article, see <http://journals.iucr.org/e>.Bis(*o*-chlorophenylbenzoylthiourea- κ S)-diiodomercury(II)

Molecules of the title compound, $[\text{HgI}_2(\text{C}_{14}\text{H}_{11}\text{ClN}_2\text{OS})_2]$, are discrete and have crystallographic twofold rotation symmetry, with the Hg atom in a four-coordinate environment. The geometry of the central Hg atom is distorted tetrahedral with bond angles in the range $99.00(8)$ – $137.56(3)^\circ$.

Comment

Several mercury–thiourea complexes reported so far have mainly involved cyclothiourea ligands; examples are $\text{Hg}(\text{C}_8\text{H}_{16}\text{N}_4\text{S}_2)\text{Cl}_2$, $\text{Hg}(\text{C}_8\text{H}_{16}\text{N}_4\text{S}_2)\text{Br}_2$, $\text{Hg}(\text{C}_8\text{H}_{16}\text{N}_4\text{S}_2)\text{I}_2$, $\text{Hg}(\text{C}_8\text{H}_{16}\text{N}_4\text{S}_2)(\text{SCN})_2$ and $\text{Hg}(\text{C}_8\text{H}_{16}\text{N}_4\text{S}_2)(\text{CN})_2$ (Popovic *et al.*, 2000). Non-cyclothiourea mercury complexes are relatively scarce and, in fact, bis $\{\mu$ -chloro-chloro[*N*-diethylaminothiocarbonyl]benzimidido-*O*-methyl ester-*S*]mercury(II)} was claimed to be the first chloro-bridged mercury–thiourea complex (Lebmann *et al.*, 2000). The title compound, (I), is probably the first mercury complex of a benzoylthiourea derivative and has twofold rotation symmetry.



The molecular structure of (I) is shown in Fig. 1 and selected geometric parameters are given in Table 1. The molecule is discrete and centrosymmetric about atom Hg1.

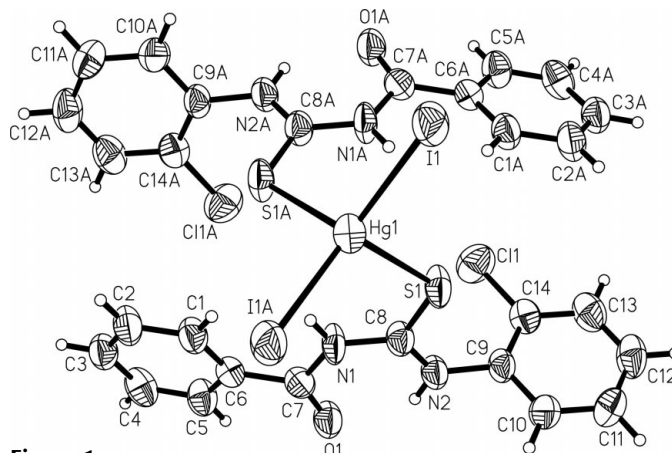


Figure 1

The molecular structure of the title compound, (I), drawn with 50% probability displacement ellipsoids. The suffix *A* corresponds to symmetry code (i) in Table 1.

The geometry of the Hg atom is distorted tetrahedral, with bond angles ranging from 99.00 (8) to 137.56 (3)°. The Hg—I bond length of 2.6582 (6) Å is slightly shorter than that in the complex Hg(C₈H₁₆N₄S₂)I₂ (Popovic *et al.*, 2000), where the corresponding bond is 2.7123 (5) Å; however, the Hg—S bond length of 2.6840 (16) Å is slightly longer [2.6119 (16) Å]. The structural dimensions of the ligand, in particular the C—S [1.690 (6) Å] and C(S)—N [1.366 (7) and 1.317 (7) Å] bond lengths, are normal and in agreement with values observed in other benzoylthiourea derivatives, such as *N*-benzoyl-*N'*-phenylthiourea [C—S = 1.6567 (15) Å, and C(S)—N = 1.393 (2) and 1.326 (2) Å] (Yamin & Yusof, 2003). The pseudo-six-membered ring (O1/C7/N1/C8/N2/H2A) in the ligand is maintained by the intramolecular interaction N2—H2A···O1 (Table 2).

Experimental

A solution of *o*-chlorophenylbenzoylthiourea (1.25 g, 4.3 mmol) in ethanol (50 ml) was added dropwise to 50 ml of an ethanol solution containing an equimolar amount of mercury(II) iodide in a two-neck round-bottomed flask. The solution was refluxed for about 2 h. The light-yellow solution was filtered and light-yellow crystals were obtained from the filtrate after evaporation for 3 d.

Crystal data

[HgI ₂ (C ₁₄ H ₁₁ ClN ₂ OS) ₂]	$D_x = 2.128 \text{ Mg m}^{-3}$
$M_r = 1035.91$	Mo $K\alpha$ radiation
Monoclinic, $C2/c$	Cell parameters from 3229 reflections
$a = 20.900$ (4) Å	$\theta = 2.2\text{--}27.6^\circ$
$b = 8.850$ (2) Å	$\mu = 7.00 \text{ mm}^{-1}$
$c = 19.845$ (4) Å	$T = 293$ (2) K
$\beta = 118.26$ (3)°	Slab, light yellow
$V = 3233.1$ (1) Å ³	0.24 × 0.11 × 0.08 mm
$Z = 4$	

Data collection

Bruker SMART APEX CCD area-detector	3734 independent reflections
ω scans	2980 reflections with $I > 2\sigma(I)$
Absorption correction: multi-scan (SADABS; Sheldrick, 1996)	$R_{\text{int}} = 0.040$
$T_{\text{min}} = 0.269$, $T_{\text{max}} = 0.571$	$\theta_{\text{max}} = 27.6^\circ$
10 696 measured reflections	$h = -21 \rightarrow 27$
	$k = -10 \rightarrow 11$
	$l = -25 \rightarrow 25$

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F_o^2) + (0.0424P)^2 + 0.7273P]$
$R[F^2 > 2\sigma(F^2)] = 0.042$	where $P = (F_o^2 + 2F_c^2)/3$
$wR(F^2) = 0.098$	$(\Delta/\sigma)_{\text{max}} < 0.001$
$S = 1.07$	$\Delta\rho_{\text{max}} = 1.33 \text{ e } \text{Å}^{-3}$
3734 reflections	$\Delta\rho_{\text{min}} = -0.67 \text{ e } \text{Å}^{-3}$
186 parameters	
H-atom parameters constrained	

Table 1

Selected geometric parameters (Å, °).

Hg1—I1	2.6582 (6)	O1—C7	1.213 (6)
Hg1—S1	2.6840 (16)	N1—C8	1.366 (7)
S1—C8	1.690 (6)	N2—C8	1.317 (7)
Cl1—C14	1.721 (6)		
I1—Hg1—I1 ⁱ	137.56 (3)	I1 ⁱ —Hg1—S1 ⁱ	99.55 (4)
I1—Hg1—S1 ⁱ	107.71 (4)	S1 ⁱ —Hg1—S1	99.00 (8)

Symmetry code: (i) $-x, y, \frac{1}{2} - z$.

Table 2

Hydrogen-bonding geometry (Å, °).

$D\text{—}H\cdots A$	$D\text{—}H$	$H\cdots A$	$D\cdots A$	$D\text{—}H\cdots A$
N2—H2A···O1	0.86	1.93	2.604 (7)	134

After checking their presence in Fourier difference maps, all the H atoms were positioned geometrically and allowed to ride on the parent C or N atoms, with C—H = 0.93–0.97 Å and N—H = 0.86 Å, and with $U_{\text{iso}}(\text{H}) = 1.2U_{\text{eq}}(\text{C or N})$. The highest electron-density peak is located at 0.82 Å from I1.

Data collection: *SMART* (Siemens, 1996); cell refinement: *SAINT* (Siemens, 1996); data reduction: *SAINT*; program(s) used to solve structure: *SHELXTL* (Sheldrick, 1997); program(s) used to refine structure: *SHELXTL*; molecular graphics: *SHELXTL*; software used to prepare material for publication: *SHELXTL*, *PARST* (Nardelli, 1995) and *PLATON* (Spek, 2003).

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References

- Lebmann, F., Beyer, L. & Sieler, J. (2000). *Inorg. Chem. Commun.* **3**, 62–67.
- Nardelli, M. (1995). *J. Appl. Cryst.* **28**, 659.
- Popovic, Z., Pavlovic, G., Calogovic, D. M., Soldin, Z., Rajic, M., Topic, V. & Kovacek, D. (2000). *Inorg. Chim. Acta*, **306**, 142–152.
- Sheldrick, G. M. (1996). *SADABS*. University of Göttingen, Germany.
- Sheldrick, G. M. (1997). *SHELXTL*. Version 5.1. Bruker AXS Inc., Madison, Wisconsin, USA.
- Siemens (1996). *SMART* and *SAINT*. Siemens Analytical X-ray Instruments Inc., Madison, Wisconsin, USA.
- Spek, A. L. (2003). *J. Appl. Cryst.* **36**, 7–13.
- Yamin, B. M. & Yusof, M. S. M. (2003). *Acta Cryst.* **E59**, o151–o152.